Resonant Cavity LED's Optimized for Coupling to Polymer Optical Fibers

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Abstract— Planar resonant-cavity light-emitting diodes have been optimized to meet optical interconnect requirements. The microcavity effect is exploited to increase the extraction efficiency into a given numerical aperture and to reduce the crosstalk in parallel optical interconnect applications. Devices are fabricated with an overall quantum efficiency of 3.7% into a polymer optical fiber with a numerical aperture of 0.5 and a FWHM beam divergence angle of 105° at a drive current of 1 mA.

Index Terms—Light-emitting diodes, microcavity, polymer optical fiber, resonant cavity.

I. INTRODUCTION

IGHT-EMITTING diodes (LED's) are key components in the optoelectronics industry. Their advantages are robustness, reliability, low temperature sensitivity, low cost and eye safety. In high-performance telecommunication systems however, due to the high-modulation bandwidth and power level requirements, laser diodes are used. New growing application areas, such as FTTH and low-cost parallel interconnects, requiring low-cost, highly reliable, and eyesafe components, offer new market segments for LED's. In guided-wave interconnect applications, light is coupled into a waveguide, e.g., based on glass fiber [with a typical numerical aperture (NA) of 0.2] or polymer optical fiber (with a typical NA of 0.5). The optical sources should be optimized such that coupled optical power is maximized, while avoiding crosstalk. This implies that the emitted light beam should exhibit low divergence, and the extraction efficiency into the numerical aperture of the waveguide is a key parameter.

The microcavity effect has been shown to influence the spontaneous emission process such that extraction efficiencies up to 10 times higher than in conventional planar LED's are obtained [1]. The microcavity effect provides a redistribution of emitted light through enhancement or inhibition of spontaneous emission, depending on the position of the emission dipole with respect to the cavity standing wave pattern. This effect is used in resonant cavity LED's (or microcavity LED's) to influence the overall quantum efficiency (QE), the far-

Manuscript received November 9, 1998. This work was supported by the IWT, Vlaams Instituut voor de bevordering van het Wetenschappelijk-Technologisch onderzoek in de industrie, by the European Community within the framework of ESPRIT-OIIC Project 22641, and by the Belgian DWTC through the IUAP-13 project.

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Publisher Item Identifier S 1041-1135(99)01116-7.

E-field gold mirror p++ GaAs contact layer phase matching GaAs layer AlGaAs cavity with 3 InGaAs QWs AlAs/GaAs DBR

Fig. 1. Layer structure of RCLED, with standing wave pattern.

field pattern and/or the spectral width of the emitted light. Moreover, these devices show good modulation characteristics [2]. Other work has been done to integrate the resonantcavity LED (RCLED) with active drive circuits [3] and to decrease the full-width at half-maximum (FWHM) emission angle [4]. Perhaps the biggest success achieved with RCLED's has been to increase the overall QE of planar LED's to 22.3% [5] (this high efficiency is a result of a combination of the microcavity effect and photon-recycling, implying relatively large device diameters). In this letter, we present theoretical and experimental results on the optimization of small diameter RCLED's for low-beam divergence and high overall QE into a limited NA of 0.5.

II. SIMULATIONS

The generic microcavity structure under investigation is shown in Fig. 1, and consists of a gold mirror, an AlGaAs λ -cavity and a GaAs–AlAs distributed Bragg reflector (DBR). An InGaAs active layer (emitting at 980 nm) was chosen to study the effect of a microcavity to enhance the coupling to NA, although the absorption of the polymer optical fiber (POF) is large (about 10 dB/m) at these wavelengths. However, at short distance communications (e.g., parallel interconnects between chips), this attenuation becomes negligible.

Simulations were done to study the effect of the cavity length and the number of DBR pairs on the beam divergence and the extraction efficiency into the limited NA (i.e., the number of photons escaping the cavity into the NA to the number of emitted photons by the active layer). A dedicated

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Fig. 2. Calculated extraction efficiency into NA = 0.5 and FWHM angle of planar RCLED structure shown in Fig 1.

RCLED model was used to evaluate numerically the extraction efficiency of several structures [6]. This model takes into account radiating as well as guided modes. It was found that up to 34% of the spontaneous emitted power from the active layer is captured in laterally guided modes of the cavity. Fortunately, part of these photons can be reabsorbed by the active layers and reemitted subsequently. This "photon recycling" effect considerably increases the overall QE of the device, as an emitted photon has a higher probability to leave the cavity. It also reduces the modulation speed of the RCLED's.

The reabsorption effect decreases at higher current levels as the carriers density comes closer to the transparency carrier density. Moreover, a part of the guided photons will escape the cavity at the border of the LED before they get reabsorbed by the active layer. For high current densities and small devices (diameter smaller than the absorption length of the waveguide), these edge effects become dominant and there will be no increase of efficiency nor decrease of modulation frequency. Modulation experiments on these devices have been carried out, and error-free transmission (BER < 10^{-12}) has been proven at 600 Mb/s [7].

The simulation results are shown in Fig. 2, where the extraction efficiency into NA = 0.5 and the FWHM angle of the RCLED are plotted as a function of the thickness of the GaAs phase matching layer and corresponding cavity resonance wavelength. The total-cavity thickness can be calculated from the resonance condition: the electrical field amplitude at the active layer position should be maximized for the quantum well peak emission wavelength. This corresponds to a GaAs layer of 119.5 nm. However, a small "detuning" further increases the extraction efficiency, as this implies an increased extraction efficiency for the nonperpendicular propagating modes. The optimal GaAs layer thickness was found to be 121 nm, the corresponding cavity resonance wavelength is 981 nm.

The influence of the DBR-reflectivity was also evaluated, and it was found that the optimal reflectivity of the DBR corresponds to a cavity bandwidth equal to the intrinsic spontaneous emission spectral width (i.e., without cavity). As this spectral width depends on the current density, it implies that the extraction efficiency also depends on the current density, and RCLED's driven at higher currents will exhibit a decreased extraction efficiency. The optimal reflection of the DBR at an intrinsic spontaneous emission spectral width of 30 nm (corresponding to a current density in the order of 100 A/cm²), is 70.8% amplitude reflection (50.2% power reflection), corresponding to a five pairs GaAs–AlAs DBR. Fig. 2 shows the tradeoff between a low beam divergence and a high extraction efficiency into NA = 0.5.

For the given device structure, the maximal extraction efficiency into NA = 0.5 is found to be 7.8%. In that case, the total extraction efficiency is 19.7%.

III. DEVICE FABRICATION

The layer structure as shown in Fig. 1 was grown on an n-doped GaAs substrate in an MOCVD reactor, and consists of 5 Si-doped DBR pairs (84.5-nm AlAs and 70-nm GaAs), followed by a 51.6-nm Al_{0.4}Ga_{0.6}As cladding layer, three 6nm-thick In_{0.2}Ga_{0.8}As quantum wells with 6-nm Al_{0.2}Ga_{0.8}As barrier layers and again a 50.6-nm Al_{0.4}Ga_{0.6}As cladding layer. Two layer structures with different GaAs phase matching layers determining the cavity resonance were grown to investigate the detuning effect: 108- and 120-nm-thick top AlGaAs layers, followed by a p⁺⁺ GaAs contact layer (Zn doped) and a gold contact, also serving as the highly reflective mirror and defining the diameter of the RCLED. Different diameters are realized (20, 30, 40, 50, 70, and 85 μ m). Mesas are defined by a shallow self-aligned wet etch, using the metal mirrors as mask pattern. The etch depth was about 130 nm, just through the heavily p⁺⁺ doped GaAs contact layer and well above the active layer. This provides a current confinement mechanism.

The n-doped GaAs substrate was thinned down to 250 μ m to reduce the absorption. An AR coating was deposited on the back surface to reduce the Fresnel losses. To allow an easy fiber alignment, the RCLED's were flip-chip mounted onto a glass carrier using direct Au–Au contacts and a UV-cured adhesive [8].

IV. MEASUREMENTS

The overall QE values and divergence angles at 1 mA were found to be 7.2% and 85° for the 108-nm RCLED, and 11.4% and 105° for the 120-nm RCLED. We calculated the QE into NA = 0.5 for a 50- μ m-diameter device, from the measured far-field pattern, resulting in a value of 4.1%. Fig. 3 compares the QE into NA = 0.5 and the QE outside the NA (a measure of the crosstalk) for the 108-nm RCLED, the 120-nm RCLED, the highly efficient RCLED [5] and an ideal planar LED. The highly efficient RCLED has a 2-mm diameter, resulting in an increased overall QE due to the recycling effect. This graph shows that, by tuning the cavity, a small RCLED has the same QE into NA = 0.5 at a smaller crosstalk level. The efficiency decreases at higher currents due to broader intrinsic spontaneous emission spectra and internal heating, resulting in a saturation of the optical power. The saturation power is proportional to the RCLED area, and is 1.54 mW for the $30-\mu$ m-diameter RCLED. The temperature dependence of the



Fig. 3. Comparison of QE into NA = 0.5 for different LED's.



Fig. 4. Measured QE at 2-mA drive current into 62.5/125 multimode glass fiber and $500-\mu$ m POF.

RCLED was evaluated, resulting in a relative power decrease of 0.8% per degree.

The coupling between the RCLED and different fiber types was evaluated. To this end, flip-chip mounted devices were aligned using an XYZ-translation block to the fibers. Two different fiber types were investigated: 62.5/125 gradient index (GRIN) multimode glass fiber (MM fiber) and 500- μ m POF. A difficulty in the coupling experiments with the POF's is the repeatability of the fiber facet quality. We used a hot knife technique, followed by polishing step, to obtain smooth POF surfaces [9].

The difference between the QE into NA = 0.5 (4.1%) and the measured QE into the fiber (3.7%) can be explained by reflection losses at the fiber facet and the partial overlap between the RCLED and the fiber facet. This overlap efficiency is given by the fraction of the rays emitted by the RCLED, within the acceptance angle of the fiber, that hit the fiber core. This geometrical overlap efficiency is dependent on the fiber and RCLED diameter, and the distance between RCLED and fiber. For small RCLED's close to the fiber facet, this overlap efficiency is 1, as all light from the RCLED within the NA of the fiber hits the fiber facet. For large RCLED's positioned close to the fibers this value is proportional to R^{-2} (with R the radius of the RCLED active area). The reflection losses at the fiber facet includes the Fresnel losses (about 5% at the glass-air and polymer-air interface), but also scattering due to small irregularities at the fiber facet.

Fig. 4 shows the measured QE into POF (diameter = 500 μ m) and multimode glass fiber (diameter 62.5 μ m) for different RCLED diameters at a constant drive current of 2 mA. This QE obtains a maximal value for RCLED diameters roughly equal to the fiber diameter. If the RCLED diameter is smaller than the fiber diameter, the extraction efficiency decreases due to an increased current density, and larger RCLED's suffer from a low overlap efficiency. This is shown in Fig. 4, where the overall QE into MM glass fiber decreases for RCLED larger than 70 μ m.

V. CONCLUSION

We fabricated planar RCLED's with an optimized cavity to maximize the extraction efficiency and minimize crosstalk. We found on a theoretical basis that there is a tradeoff between high extraction efficiency and low beam divergence. The maximum theoretical extraction efficiency into the numerical aperture of a polymer optical fiber for planar RCLED's with 30-nm intrinsic spontaneous emission spectral width is 7.8%. Devices were fabricated, and the QE into NA = 0.5 was found to be 4.1%. The measured QE into 500- μ m POF was found to be 3.7%.

ACKNOWLEDGMENT

The authors wish to acknowledge S. Verstuyft for the processing, L. Van Wassenhove for the flip-chip mounting, and A. Van Hove for supplying terminated POF.

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